



N-channel 650 V, 0.093 Ω typ., 32 A MDmesh™ DM2 Power MOSFET in a TO-220 package

Datasheet - production data

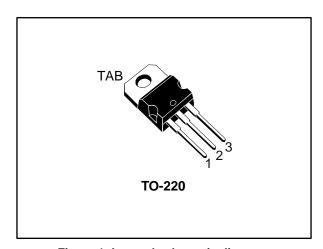
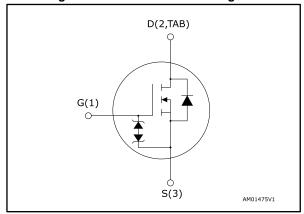


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	I _D	Ртот
STP35N65DM2	650 V	0.110 Ω	32 A	250 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmesh $^{\text{TM}}$ DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low R_{DS(on)}, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STP35N65DM2	35N65DM2	TO-220	Tube

Contents STP35N65DM2

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STP35N65DM2 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _G s	Gate-source voltage	±25	V
l-	Drain current (continuous) at T _{case} = 25 °C	32	۸
ID	Drain current (continuous) at T _{case} = 100 °C	20	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	90	Α
P _{TOT}	Total dissipation at T _{case} = 25 °C	250	W
dv/dt ⁽²⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	V/IIS
T _{stg}	Storage temperature range	-55 to 150	°C
Tj	Operating junction temperature range	-55 (0 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	0.5	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	62.5 °C	

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or non-repetitive	4	Α
E _{AS} ⁽¹⁾	Single pulse avalanche energy	1150	mJ

Notes:

⁽¹⁾Pulse width is limited by safe operating area.

 $^{^{(2)}}I_{SD} \leq 32$ A, di/dt=900 A/ μ s, V $_{DS}$ peak < V $_{(BR)DSS}$, V $_{DD}$ = 80% V $_{(BR)DSS}$

 $^{^{(3)}}V_{DS} \le 520 \ V$

 $^{^{(1)}}Starting~T_{j}=25~^{\circ}C,~I_{D}=I_{AR},~V_{DD}=50~V.$

Electrical characteristics STP35N65DM2

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	650			V
	Zoro goto voltago droin	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V}$			1	
IDSS	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 650 \text{ V},$ $T_{case} = 125 \text{ °C}^{(1)}$			100	μΑ
Igss	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = ±25 V			±5	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 16 A		0.093	0.110	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	2540	ı	
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	115	ı	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	2.5	-	Pi
Coss eq. (1)	Equivalent output capacitance	V _{DS} = 0 to 520 V, V _{GS} = 0 V	-	204	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	4.2	-	Ω
Q_g	Total gate charge	$V_{DD} = 520 \text{ V}, I_D = 32 \text{ A}, V_{GS} = 0$	-	56.3	-	
Qgs	Gate-source charge	to 10 V (see Figure 15: "Test	-	12.7	-	nC
Q _{gd}	Gate-drain charge	circuit for gate charge behavior")	-	27.6	-	

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 325 \text{ V}, I_D = 16 \text{ A}, R_G = 4.7 \Omega,$	ı	23.4	ı	
tr	Rise time	V _{GS} = 10 V (see Figure 14: "Test circuit for resistive load switching		23	-	
t _{d(off)}	Turn-off delay time	times" and Figure 19: "Switching	-	72	-	ns
t _f	Fall time	time waveform")	-	10.4	-	

⁽¹⁾Defined by design, not subject to production test.

 $^{^{(1)}}$ Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDs increases from 0 to 80% VDss.

Table 8: Source-drain diode

Symbol	Parameter	Test conditions		Тур.	Max.	Unit
I _{SD}	Source-drain current		-		32	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				90	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 32 A	-		1.6	V
trr	Reverse recovery time		-	100		ns
Qrr	Reverse recovery charge	I _{SD} = 32 A, di/dt = 100 A/μs, V _{DD} = 60 V (see <i>Figure 16: "Test</i> <i>circuit for inductive load switching</i>	-	0.42		μC
I _{RRM}	Reverse recovery current	and diode recovery times")	-	8.4		Α
trr	Reverse recovery time	I _{SD} = 32 A, di/dt = 100 A/µs,	-	205		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, T _i = 150 °C (see Figure 16: "Test circuit for	-	1.8		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	17.6		Α

Notes:

⁽¹⁾Pulse width is limited by safe operating area.

 $^{^{(2)}\}text{Pulse}$ test: pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2: Safe operating area GADG061220171022SOA **I**_D (A) Operation in this area is limited by R_{DS(on)} 10² tॢ=1 µs t_o=10 μs 10¹ t,=100 µs t₀=1 ms t₀=10 ms 10⁰ T_i≤150 °C T_.= 25°C single pulse 10- $\vec{V}_{DS}(V)$ 10⁰ 10¹ 10-1

Figure 3: Thermal impedance

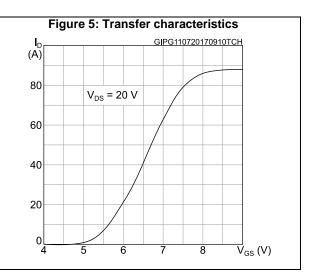
K $\delta = 0.5$ 0.2

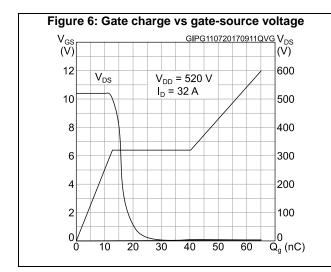
0.1

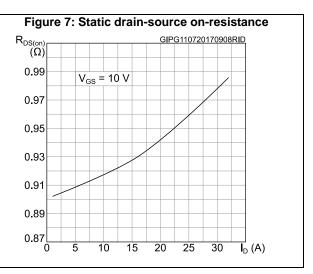
0.05

0.01

SINGLE PULSE $\delta = t_p/\tau$ $\delta = t_p/\tau$

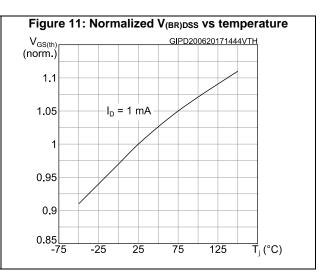


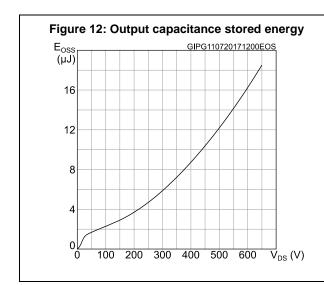


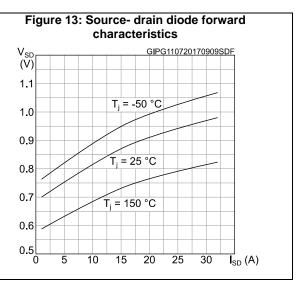


STP35N65DM2 Electrical characteristics

Figure 8: Capacitance variations GIPG110720170909CVR (pF) 10^{4} C_{ISS} 10^{3} 10² Coss 10¹ f = 1 MHz C_{RSS} 10⁰ 10⁻¹ 10⁰ 10¹ 10² $\vec{V}_{DS}(V)$







Test circuits STP35N65DM2

3 Test circuits

Figure 14: Test circuit for resistive load switching times

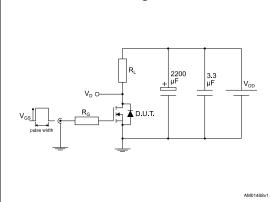


Figure 16: Test circuit for inductive load switching and diode recovery times

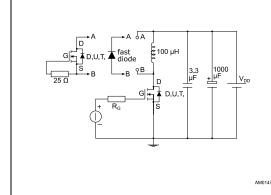


Figure 17: Unclamped inductive load test circuit

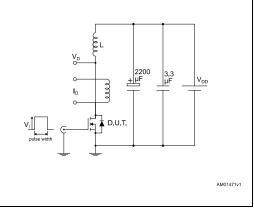


Figure 18: Unclamped inductive waveform

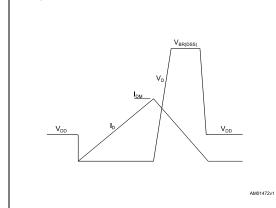
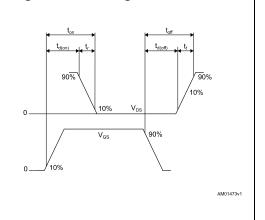


Figure 19: Switching time waveform



4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220 type A package information

Figure 20: TO-220 type A package outline

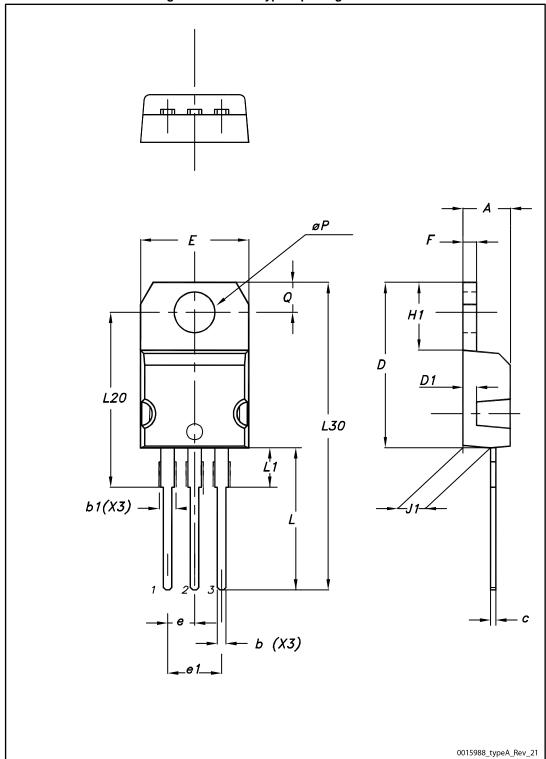


Table 9: TO-220 type A package mechanical data

Dim	,	mm	
Dim.	Min.	Тур.	Max.
А	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
С	0.48		0.70
D	15.25		15.75
D1		1.27	
Е	10.00		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13.00		14.00
L1	3.50		3.93
L20		16.40	
L30		28.90	
øΡ	3.75		3.85
Q	2.65		2.95

Revision history STP35N65DM2

5 Revision history

Table 10: Document revision history

Date	Revisi on	Changes
21-Jul-2017	1	Initial release
6-Dec-2017	2	Document status changed from preliminary to production data. Updated Table 2: "Absolute maximum ratings" and Table 8: "Source-drain diode". Updated Figure 2: "Safe operating area". Minor text changes.

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